

## CoolMOS™ Power Transistor

### Features

- New revolutionary high voltage technology
- Extreme dv/dt rated
- High peak current capability
- Fully qualified according to JEDEC<sup>1)</sup> for industrial applications
- Pb-free lead plating; RoHS compliant; Halogen free mold compound
- Ultra low gate charge
- Ultra low effective capacitances

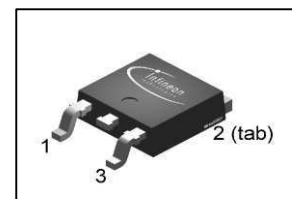
### CoolMOS™ 800V designed for:

- Industrial application with high DC bulk voltage
- Switching Application ( i.e. active clamp forward )

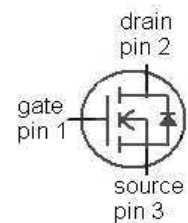
### Product Summary

|  |     |          |
|--|-----|----------|
| $V_{DS}$                                   | 800 | V        |
| $R_{DS(on)max}$ @ $T_j = 25^\circ\text{C}$ | 2.7 | $\Omega$ |
| $Q_{g,typ}$                                | 12  | nC       |

PG-TO252-3



| Type       | Package    | Marking |
|------------|------------|---------|
| SPD02N80C3 | PG-TO252-3 | 02N80C3 |



**Maximum ratings**, at  $T_j=25^\circ\text{C}$ , unless otherwise specified

| Parameter                                      | Symbol         | Conditions                           | Value       | Unit             |
|--|----------------|--------------------------------------|-------------|------------------|
| Continuous drain current                       | $I_D$          | $T_C=25^\circ\text{C}$               | 2           | A                |
|  |                | $T_C=100^\circ\text{C}$              | 1.2         |                  |
| Pulsed drain current <sup>2)</sup>             | $I_{D,pulse}$  | $T_C=25^\circ\text{C}$               | 6           |                  |
| Avalanche energy, single pulse                 | $E_{AS}$       | $I_D=1\text{ A}, V_{DD}=50\text{ V}$ | 90          | mJ               |
| Avalanche energy, repetitive $t_{AR}^{2),3)}$  | $E_{AR}$       | $I_D=2\text{ A}, V_{DD}=50\text{ V}$ | 0.05        |                  |
| Avalanche current, repetitive $t_{AR}^{2),3)}$ | $I_{AR}$       |                                      | 2           | A                |
| MOSFET dv/dt ruggedness                        | dv/dt          | $V_{DS}=0\dots640\text{ V}$          | 50          | V/ns             |
| Gate source voltage                            | $V_{GS}$       | static                               | $\pm 20$    | V                |
|  |                | AC ( $f > 1\text{ Hz}$ )             | $\pm 30$    |                  |
| Power dissipation                              | $P_{tot}$      | $T_C=25^\circ\text{C}$               | 42          | W                |
| Operating and storage temperature              | $T_j, T_{stg}$ |                                      | -55 ... 150 | $^\circ\text{C}$ |

**Maximum ratings**, at  $T_j=25\text{ °C}$ , unless otherwise specified

| Parameter                           | Symbol        | Conditions         | Value | Unit |
|-------------------------------------|---------------|--------------------|-------|------|
| Continuous diode forward current    | $I_S$         | $T_C=25\text{ °C}$ | 2     | A    |
| Diode pulse current <sup>2)</sup>   | $I_{S,pulse}$ |                    | 6     |      |
| Reverse diode $dv/dt$ <sup>4)</sup> | $dv/dt$       |                    | 4     | V/ns |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Thermal characteristics**

|   |            |  |   |    |     |     |
|---|------------|--|---|----|-----|-----|
| Thermal resistance, junction - case     | $R_{thJC}$ |  | - | -  | 3   | K/W |
| Thermal resistance, junction - ambient  | $R_{thJA}$ | SMD version, device on PCB, minimal footprint                            | - | -  | 62  |     |
|   |            | SMD version, device on PCB, 6 cm <sup>2</sup> cooling area <sup>5)</sup> | - | 35 | -   |     |
| Soldering temperature, reflow soldering | $T_{sold}$ | reflow MSL1  | - | -  | 260 | °C  |

**Electrical characteristics**, at  $T_j=25\text{ °C}$ , unless otherwise specified

**Static characteristics**

|                                  |               |   |     |     |     |               |
|----------------------------------|---------------|---|-----|-----|-----|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$ , $I_D=250\text{ }\mu\text{A}$                | 800 | -   | -   | V             |
| Avalanche breakdown voltage      | $V_{(BR)DS}$  | $V_{GS}=0\text{ V}$ , $I_D=2\text{ A}$                            | -   | 870 | -   |               |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}$ , $I_D=0.12\text{ mA}$                            | 2.1 | 3   | 3.9 |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=800\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ °C}$  | -   | -   | 5   | $\mu\text{A}$ |
|                                  |               | $V_{DS}=800\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=150\text{ °C}$ | -   | 25  | -   |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                        | -   | -   | 100 | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=10\text{ V}$ , $I_D=1.2\text{ A}$ , $T_j=25\text{ °C}$    | -   | 2.4 | 2.7 | $\Omega$      |
|                                  |               | $V_{GS}=10\text{ V}$ , $I_D=1.2\text{ A}$ , $T_j=150\text{ °C}$   | -   | 6.5 | -   |               |
| Gate resistance                  | $R_G$         | $f=1\text{ MHz}$ , open drain                                     | -   | 1.2 | -   | $\Omega$      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics**

|  |              |   |   |     |   |    |
|--|--------------|---|---|-----|---|----|
| Input capacitance  | $C_{iss}$    | $V_{GS}=0\text{ V}, V_{DS}=100\text{ V},$<br>$f=1\text{ MHz}$   | - | 290 | - | pF |
| Output capacitance   | $C_{oss}$    |   | - | 13  | - |    |
| Effective output capacitance, energy related <sup>6)</sup> | $C_{o(er)}$  | $V_{GS}=0\text{ V}, V_{DS}=0\text{ V}$<br>to 480 V  | - | 11  | - |    |
| Effective output capacitance, time related <sup>7)</sup>   | $C_{o(tr)}$  |   | - | 26  | - |    |
| Turn-on delay time   | $t_{d(on)}$  | $V_{DD}=400\text{ V},$<br>$V_{GS}=0/10\text{ V}, I_D=2\text{ A},$<br>$R_G=47\text{ }\Omega, T_j=25\text{ }^\circ\text{C}$ | - | 25  | - | ns |
| Rise time  | $t_r$        |   | - | 15  | - |    |
| Turn-off delay time  | $t_{d(off)}$ |   | - | 72  | - |    |
| Fall time  | $t_f$        |   | - | 18  | - |    |

**Gate Charge Characteristics**

|                       |               |  |   |     |    |    |
|-----------------------|---------------|--|---|-----|----|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=640\text{ V}, I_D=2\text{ A},$<br>$V_{GS}=0\text{ to }10\text{ V}$ | - | 1.5 | -  | nC |
| Gate to drain charge  | $Q_{gd}$      |  | - | 6   | -  |    |
| Gate charge total     | $Q_g$         |  | - | 12  | 16 |    |
| Gate plateau voltage  | $V_{plateau}$ |  | - | 5.5 | -  | V  |

**Reverse Diode**

|                               |           |   |   |     |     |               |
|-------------------------------|-----------|---|---|-----|-----|---------------|
| Diode forward voltage         | $V_{SD}$  | $V_{GS}=0\text{ V}, I_F=I_S=2\text{ A},$<br>$T_j=25\text{ }^\circ\text{C}$    | - | 1   | 1.2 | V             |
| Reverse recovery time         | $t_{rr}$  | $V_R=400\text{ V}, I_F=I_S=2\text{ A},$<br>$di_F/dt=100\text{ A}/\mu\text{s}$ | - | 520 | -   | ns            |
| Reverse recovery charge       | $Q_{rr}$  |   | - | 2   | -   | $\mu\text{C}$ |
| Peak reverse recovery current | $I_{rrm}$ |   | - | 6   | -   | A             |

<sup>1)</sup> J-STD20 and JESD22

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$ 
<sup>3)</sup> Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV}=E_{AR} \cdot f$ .

<sup>4)</sup>  $I_{SD}=I_D, di/dt=400\text{ A}/\mu\text{s}, V_{DClink}=400\text{ V}, V_{peak}<V_{(BR)DSS}, T_j<T_{j,max}$ , identical low side and high side switch

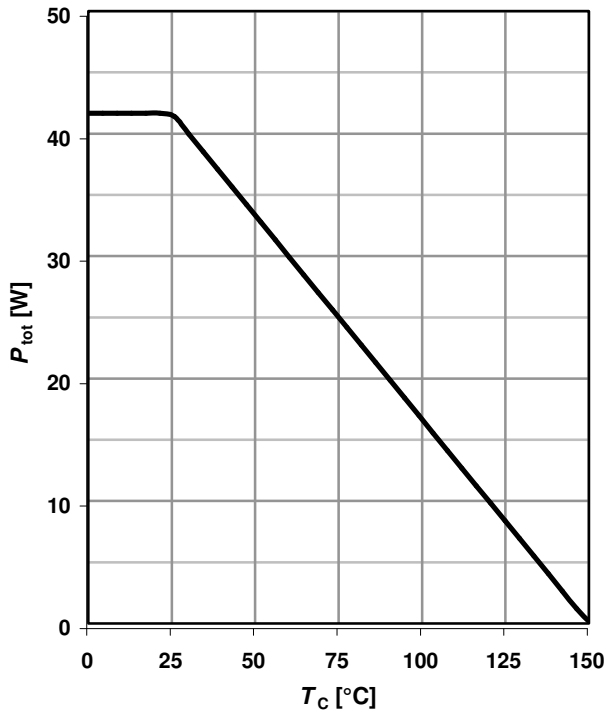
<sup>5)</sup> Device on 40mm\*40mm\*1.5 epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air

<sup>6)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>7)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

**1 Power dissipation**

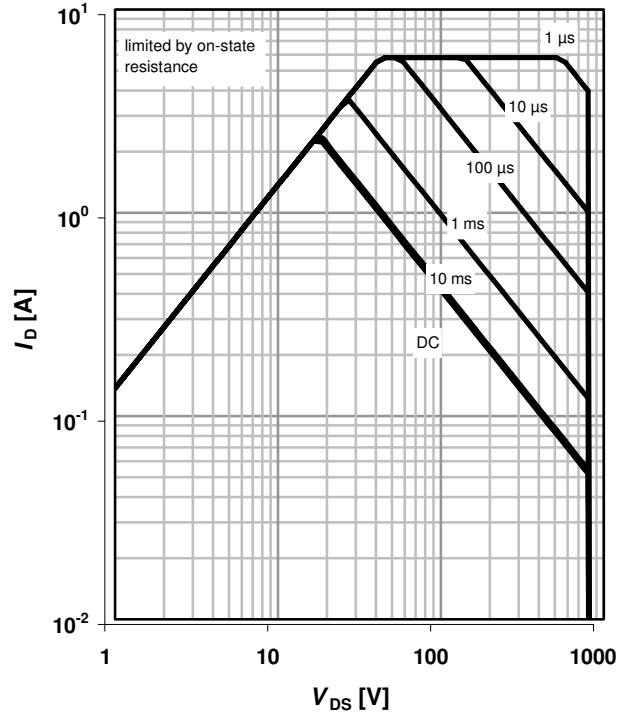
$P_{tot}=f(T_C)$



**2 Safe operating area**

$I_D=f(V_{DS}); T_C=25\text{ °C}; D=0$

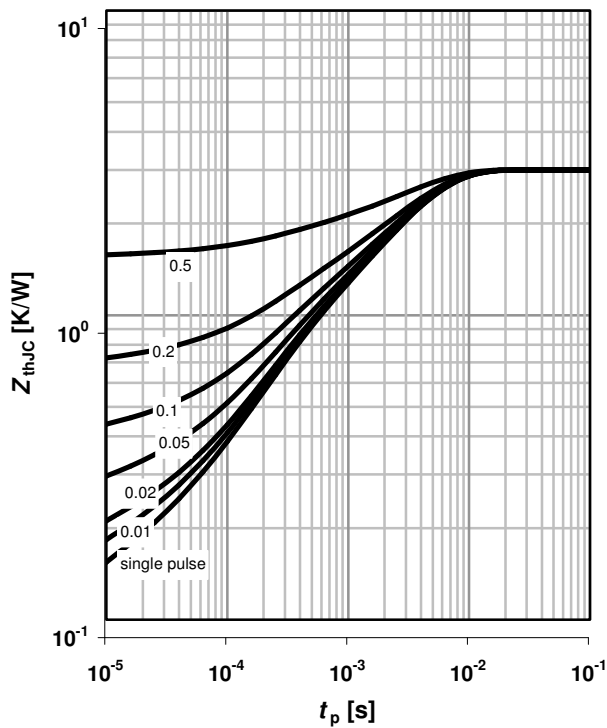
parameter:  $t_p$



**3 Max. transient thermal impedance**

$Z_{thJC}=f(t_p)$

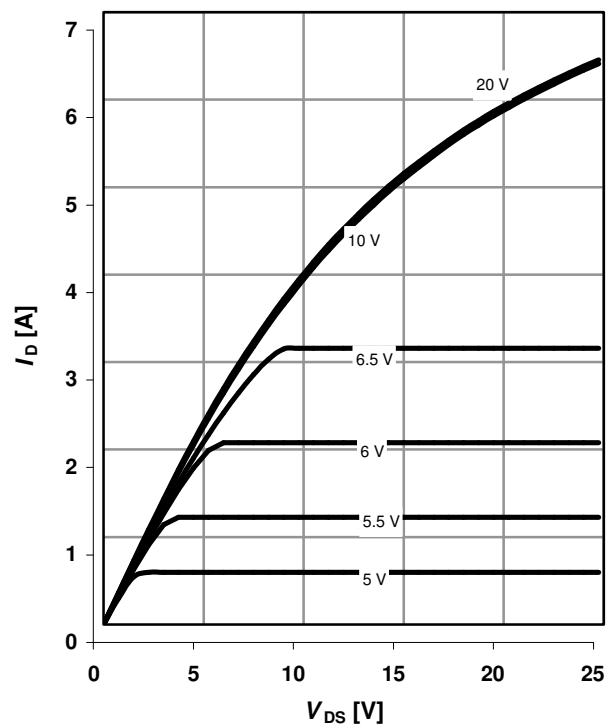
parameter:  $D=t_p/T$



**4 Typ. output characteristics**

$I_D=f(V_{DS}); T_j=25\text{ °C}; t_p=10\text{ µs}$

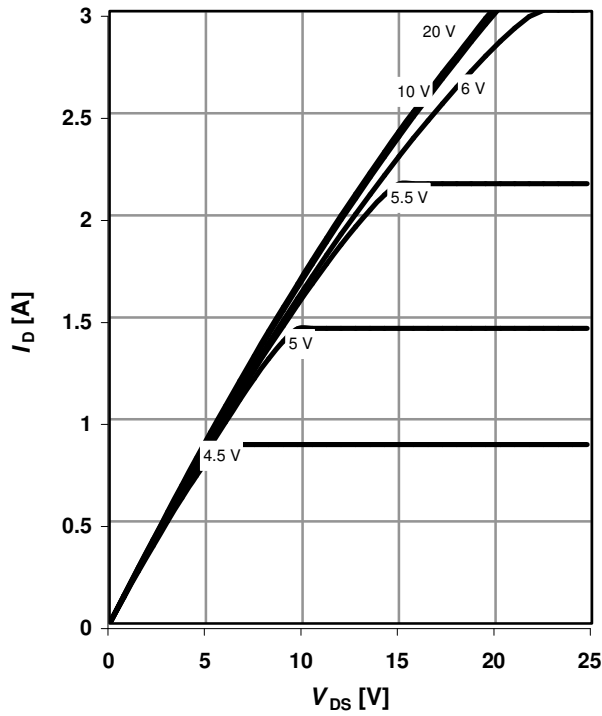
parameter:  $V_{GS}$



**5 Typ. output characteristics**

$I_D=f(V_{DS}); T_j=150\text{ }^\circ\text{C}; t_p=10\text{ }\mu\text{s}$

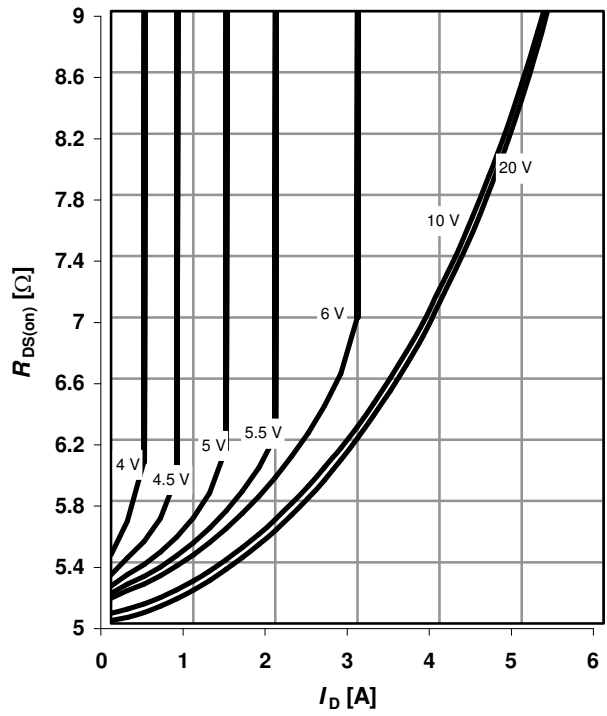
parameter:  $V_{GS}$



**6 Typ. drain-source on-state resistance**

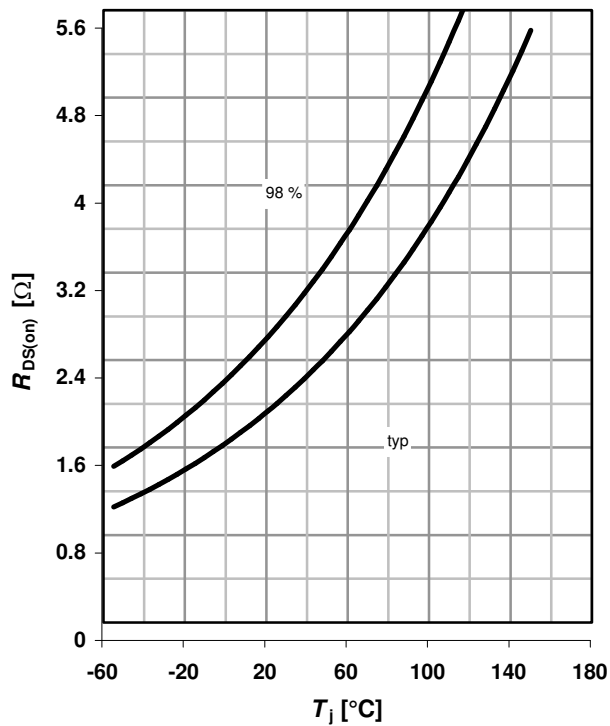
$R_{DS(on)}=f(I_D); T_j=150\text{ }^\circ\text{C}$

parameter:  $V_{GS}$



**7 Drain-source on-state resistance**

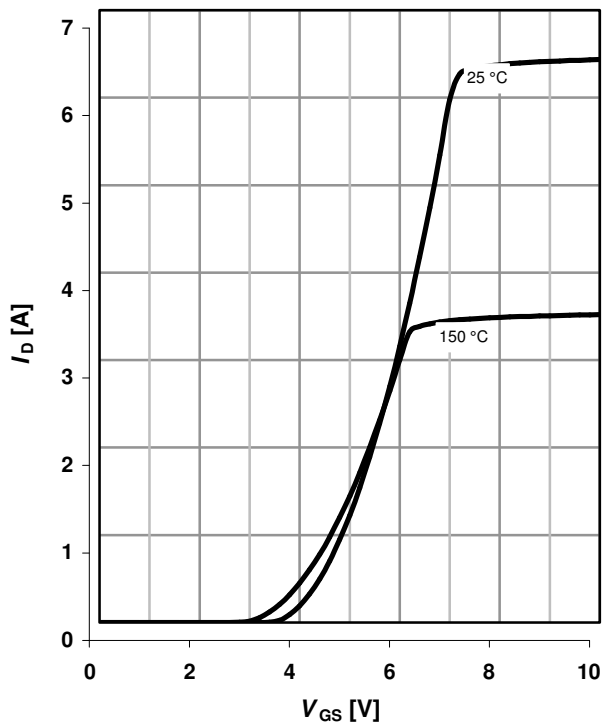
$R_{DS(on)}=f(T_j); I_D=1.2\text{ A}; V_{GS}=10\text{ V}$



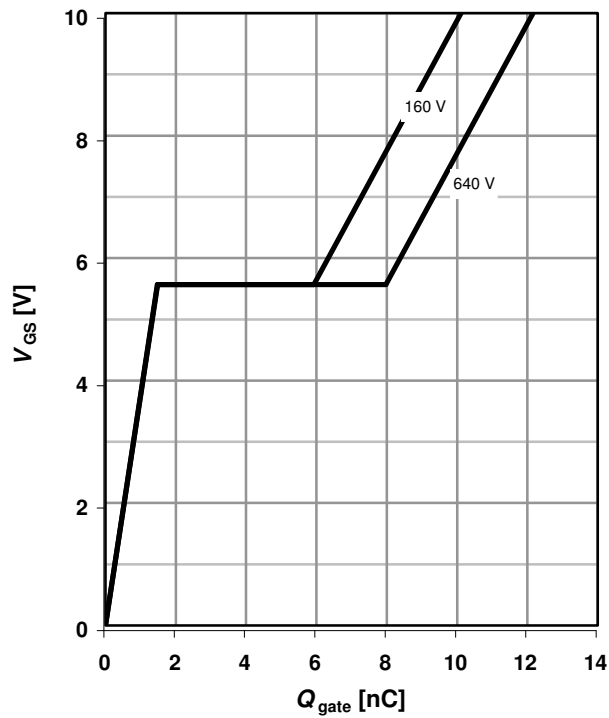
**8 Typ. transfer characteristics**

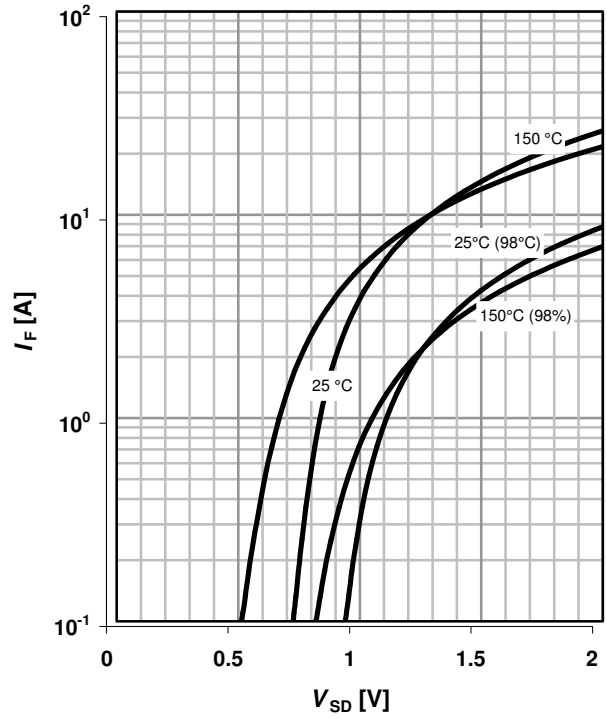
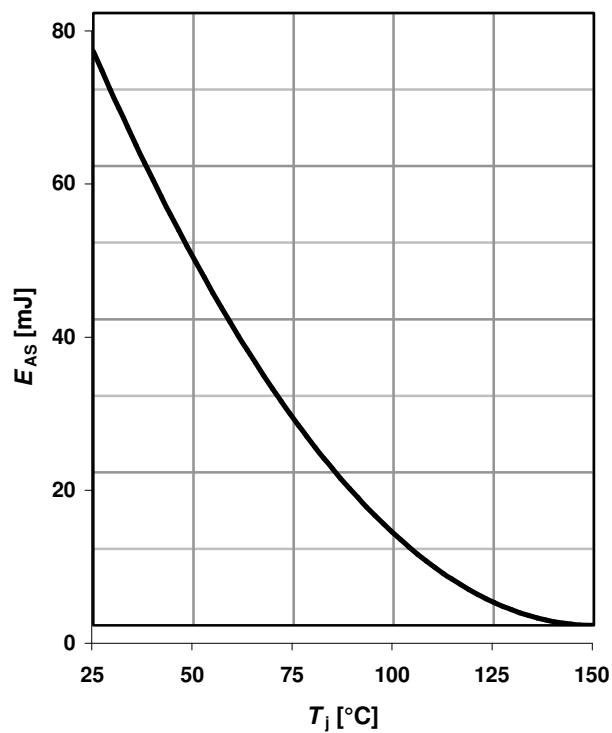
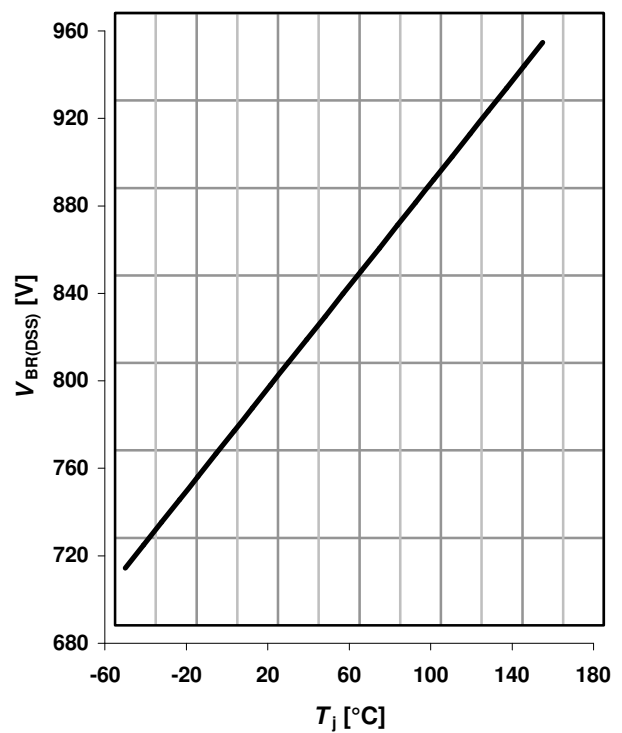
$I_D=f(V_{GS}); |V_{DS}|>2|I_D|R_{DS(on)max}; t_p=10\text{ }\mu\text{s}$

parameter:  $T_j$



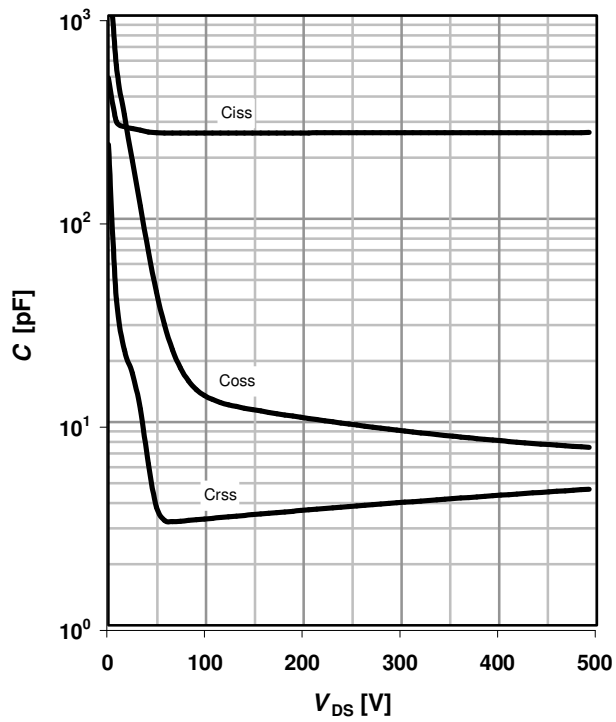
**9 Typ. gate charge**
 $V_{GS}=f(Q_{gate}); I_D=2\text{ A pulsed}$ 

 parameter:  $V_{DD}$ 

**10 Forward characteristics of reverse diode**
 $I_F=f(V_{SD}); t_p=10\ \mu\text{s}$ 

 parameter:  $T_j$ 

**11 Avalanche energy**
 $E_{AS}=f(T_j); I_D=1\text{ A}; V_{DD}=50\text{ V}$ 

**12 Drain-source breakdown voltage**
 $V_{BR(DSS)}=f(T_j); I_D=0.25\text{ mA}$ 


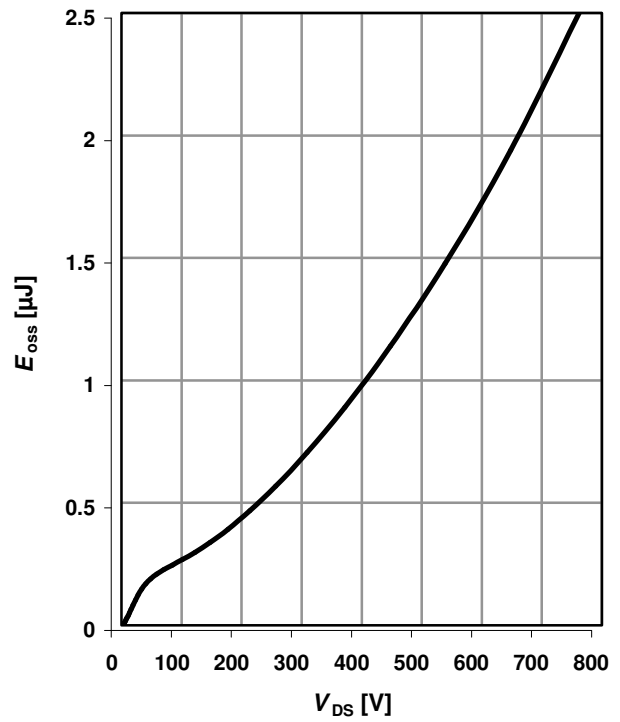
**13 Typ. capacitances**

$C=f(V_{DS}); V_{GS}=0\text{ V}; f=1\text{ MHz}$

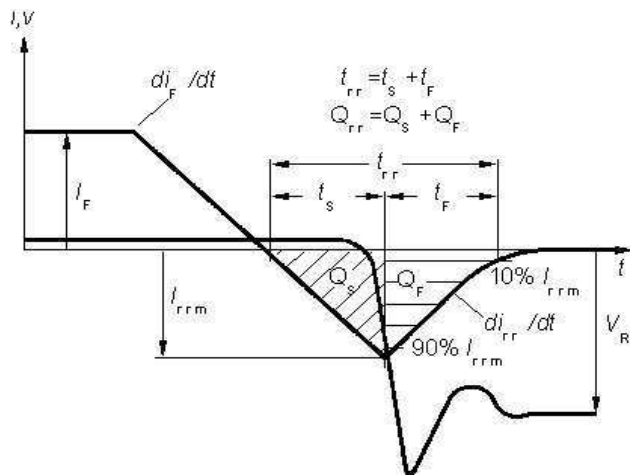


**14 Typ. Coss stored energy**

$E_{oss}=f(V_{DS})$

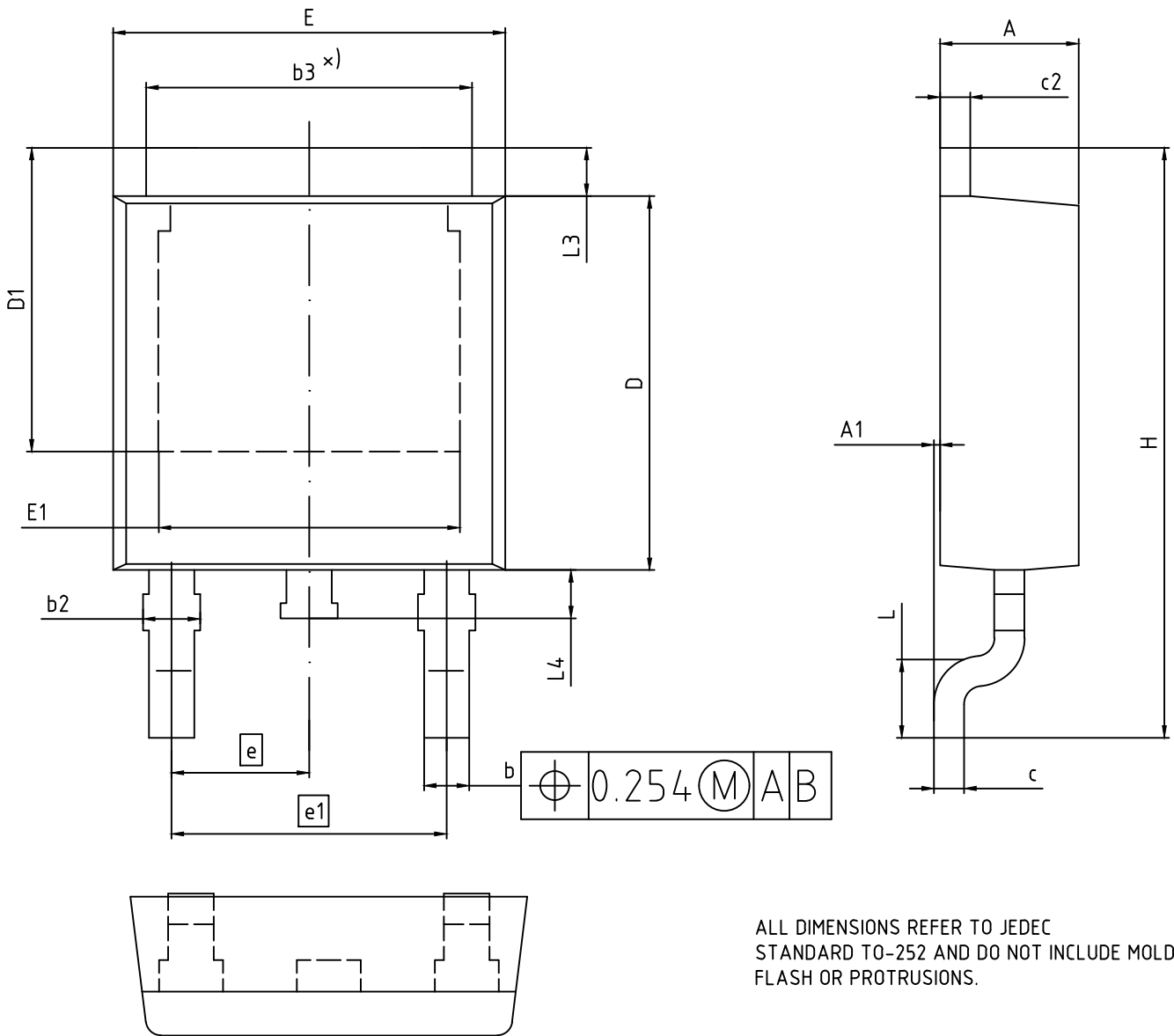


Definition of diode switching characteristics





PG-TO252-3-1: Outline , PG-TO-252-3-11 (D-PAK), PG-TO-252-3-21 (D-PAK)



ALL DIMENSIONS REFER TO JEDEC STANDARD TO-252 AND DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.

| DIMENSION | MILLIMETERS |       |
|-----------|-------------|-------|
|           | MIN.        | MAX.  |
| A         | 2.16        | 2.41  |
| A1        | 0.00        | 0.15  |
| b         | 0.64        | 0.89  |
| b2        | 0.65        | 1.15  |
| b3        | 4.95        | 5.50  |
| c         | 0.46        | 0.61  |
| c2        | 0.40        | 0.98  |
| D         | 5.97        | 6.22  |
| D1        | 5.02        | 5.84  |
| E         | 6.35        | 6.73  |
| E1        | 4.32        | 5.50  |
| e         | 2.29        |       |
| e1        | 4.57        |       |
| N         | 3           |       |
| H         | 9.40        | 10.48 |
| L         | 1.18        | 1.78  |
| L3        | 0.89        | 1.27  |
| L4        | 0.51        | 1.02  |

|                                      |
|--------------------------------------|
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| <b>REVISION</b><br>07                |
| <b>SCALE:</b><br>10:1<br>0 1 2mm<br> |
| <b>EUROPEAN PROJECTION</b><br>       |
| <b>ISSUE DATE</b><br>01.04.2020      |

## Revision History

SPD02N80C3

**Revision: 2020-05-26, Rev. 2.94**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision)                |
|----------|------------|---|
| 2.93     | 2016-04-19 | Non-halogen free version discontinued (creation:2016-04-13) |
| 2.94     | 2020-05-26 | Update package outline                                      |

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